

Search Notes

Application/Control No.

10/603,937

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

MIYAGAWA, ICHIROU

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	241, 256	5/23/2005	HP
359	196	5/23/2005	HP
369	44.23	5/23/2005	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/23/2005	HP